

Precision 2.5V FGA™ Voltage Reference

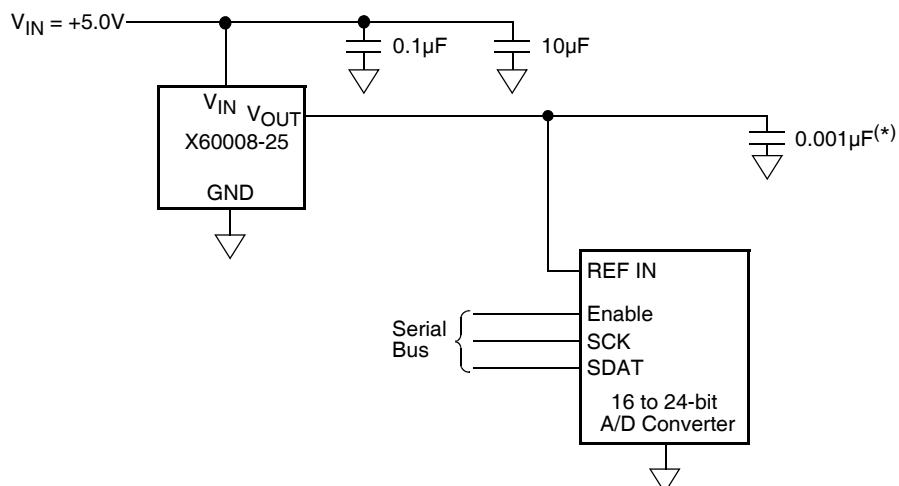
FEATURES

- Output Voltage: 2.500V
- Absolute Initial Accuracy Options: $\pm 0.5\text{mV}$ & $\pm 1.0\text{mV}$
- Ultra Low Power Supply Current: 500nA
- Low Temperature Coefficient Options: 3, 5 & 10ppm/ $^{\circ}\text{C}$
- 10mA Source & Sink Current Capability
- 10ppm/1000hrs Long Term Stability
- Supply Voltage Range: 4.5V to 6.5V
- 5kV ESD (Human Body Model)
- Standard Package: 8 Ld SOIC
- Temp Range: -40 $^{\circ}\text{C}$ to +85 $^{\circ}\text{C}$
- Pb-Free Plus Anneal Available (RoHS Compliant)

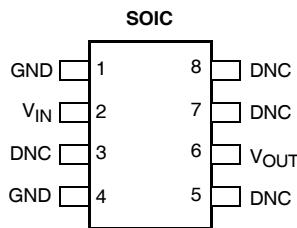
APPLICATIONS

- High Resolution A/Ds & D/As
- Digital Meters
- Calibration Systems
- V-F Converters
- Precision Current Sources
- Precision Regulators
- Precision Oscillators
- Battery Management Systems
- Smart sensors
- Strain Gage Bridges
- Threshold Detectors
- Servo Systems

TYPICAL APPLICATION



(*)Also see Figure 3 in Applications Information

PACKAGE DIAGRAM**X60008-XX****PIN CONFIGURATIONS**

Pin Name	Description
GND	Ground Connection
V _{IN}	Power Supply Input Connection
V _{OUT}	Voltage Reference Output Connection
DNC	Do Not Connect; Internal Connection – Must Be Left Floating

Ordering Information

PART NUMBER	PART MARKING	V _{OUT} (V)	GRADE	TEMPERATURE RANGE (°C)	PACKAGE	PKG. DWG. #
X60008BIS8-25*	X60008B I25	2.5	±0.5mV, 3ppm/°C	-40 to +85	8 Ld SOIC (150 mil)	MDP0027
X60008BIS8Z-25* (Note)	X60008B ZI25	2.5	±0.5mV, 3ppm/°C	-40 to +85	8 Ld SOIC (150 mil) (Pb-free)	MDP0027
X60008CIS8-25	X60008C I25	2.5	±0.5mV, 5ppm/°C	-40 to +85	8 Ld SOIC (150 mil)	MDP0027
X60008CIS8Z-25* (Note)	X60008C ZI25	2.5	±0.5mV, 5ppm/°C	-40 to +85	8 Ld SOIC (150 mil) (Pb-free)	MDP0027
X60008DIS8-25*	X60008D I25	2.5	±1.0mV, 10ppm/°C	-40 to +85	8 Ld SOIC (150 mil)	MDP0027
X60008DIS8Z-25* (Note)	X60008D ZI25	2.5	±1.0mV, 10ppm/°C	-40 to +85	8 Ld SOIC (150 mil) (Pb-free)	MDP0027

*Add "T1" suffix for tape and reel.

NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

ABSOLUTE MAXIMUM RATINGS

Storage Temperature Range.....-65°C to +125°C
 Max Voltage Applied V_{IN} to Gnd-0.5V to +6.5V
 Max Voltage Applied V_{OUT} to Gnd^(*)-0.5V to +3.5V
 Voltage on "DNC" pins..... No connections permitted to
 these pins.
 Lead Temperature, soldering^(*)+ 225°C
 (*) note: maximum duration = 10 seconds

COMMENT

Absolute Maximum Ratings are limits which may result in impaired reliability and/or permanent damage to the device. These are stress ratings provided for information only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification are not implied.

RECOMMENDED OPERATING CONDITIONS

Temperature	Min.	Max.
Industrial	-40°C	+85°C

For guaranteed specifications and test conditions, see Electrical Characteristics.

The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

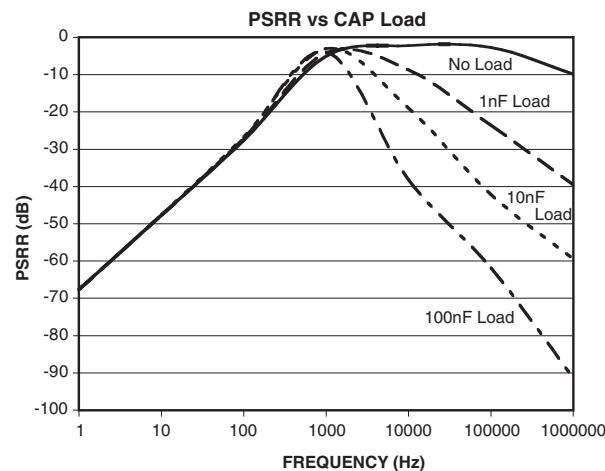
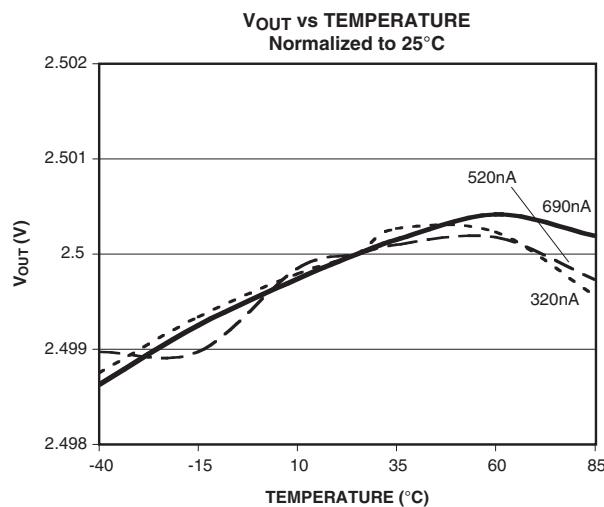
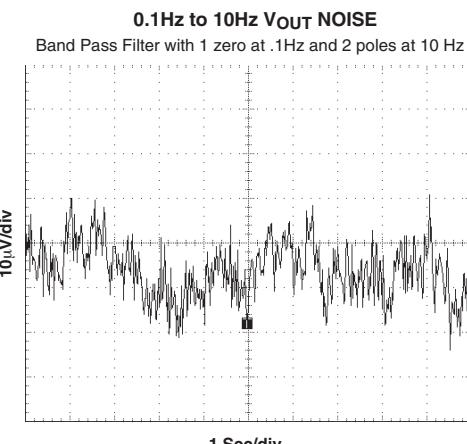
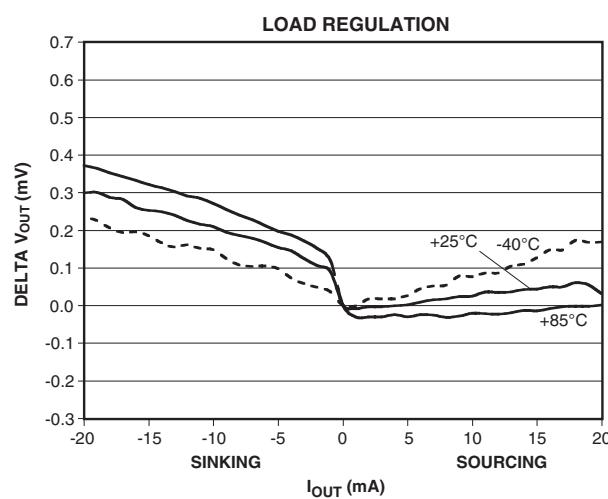
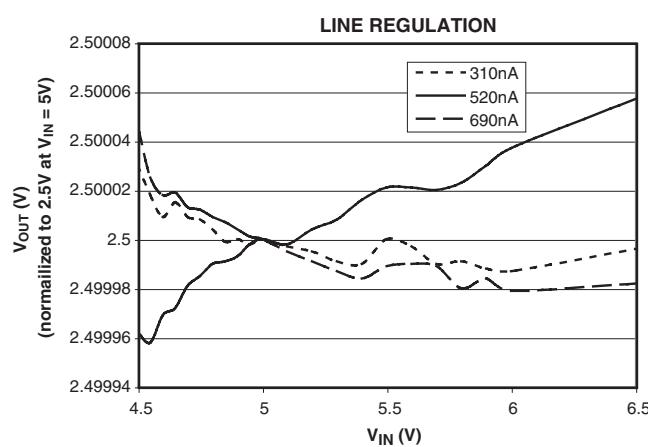
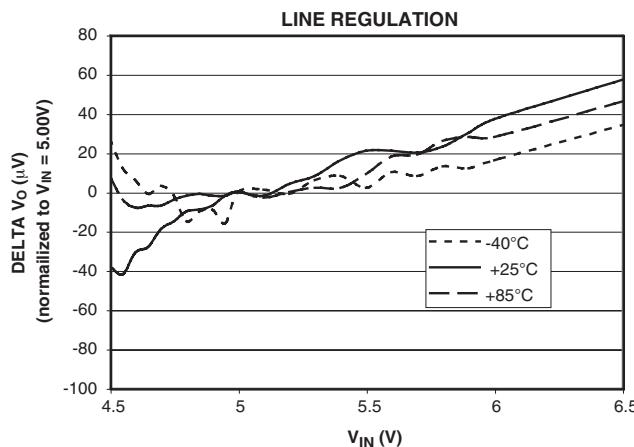
ELECTRICAL CHARACTERISTICS

(Operating Conditions: V_{IN} = 5.0V, I_{OUT} = 0mA, C_{OUT} = 0.001μF, T_A = -40 to +85°C unless otherwise specified.)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
V_{OUT}	Output Voltage			2.500		V
V_{OA}	V_{OUT} Accuracy X60008B-25 X60008C-25 X60008D-25	T_A = 25°C	-0.50 -0.50 -1.00		+0.50 +0.50 +1.00	mV
I_{IN}	Supply Current			500	800	nA
V_{IN}	Input Voltage Range		4.5		6.5	V
TC V_{OUT}	Output Voltage Temperature Coefficient ⁽¹⁾	X60008B-25 X60008C-25 X60008D-25			3 5 10	ppm/°C
$\Delta V_{OUT}/\Delta V_{IN}$	Line Regulation	$+4.5V \leq V_{IN} \leq +6.5V$			100	μV/V
$\Delta V_{OUT}/\Delta I_{OUT}$	Load Regulation	$0mA \leq I_{SOURCE} \leq 10mA$ $-10mA \leq I_{SINK} \leq 0mA$	10 20	40 80		μV/mA
$\Delta V_{OUT}/\Delta t$	Long Term Stability	T_A = 25°C		10		ppm/ 1000Hrs
$\Delta V_{OUT}/\Delta T_A$	Thermal Hysteresis ⁽²⁾	ΔT = -40°C to +85°C		50		ppm
I_{SC}	Short Circuit Current ⁽³⁾	T_A = 25°C		50	80	mA
V_N	Output Voltage Noise	0.1Hz to 10Hz		30		μV _{pp}

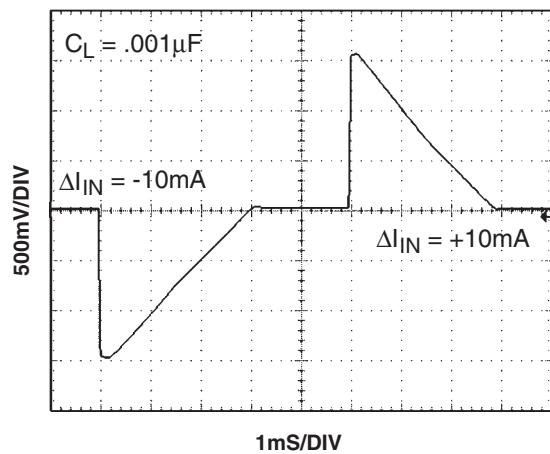
- Note:
- Over the specified temperature range. Temperature coefficient is measured by the box method whereby the change in V_{OUT} is divided by the temperature range; in this case, -40°C to +85°C = 125°C.
 - Thermal Hysteresis is the change in V_{OUT} created by package stress @ T_A = 25°C after temperature cycling. V_{OUT} is read initially at T_A = 25°C; the X60008 is then cycled between Hot (85°C) and Cold (-40°C) before a second V_{OUT} measurement is taken at 25°C. The deviation between the initial V_{OUT} reading and the second V_{OUT} reading is then expressed in ppm.
 - Guaranteed by device characterization and/or correlation to other device tests.

TYPICAL PERFORMANCE CHARACTERISTIC CURVES
($V_{IN} = 5.0V$, $I_{OUT} = 0mA$, $T_A = 25^{\circ}C$ unless otherwise specified)

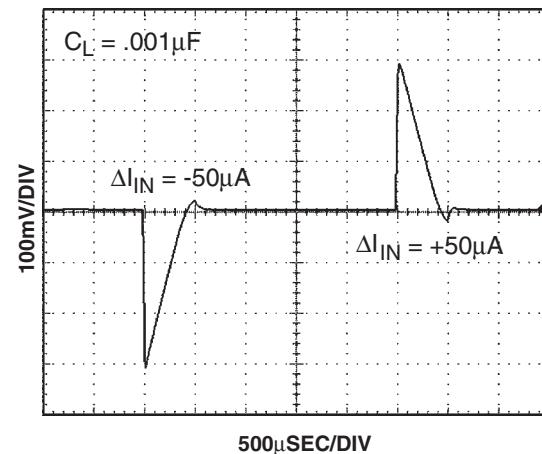


TYPICAL PERFORMANCE CHARACTERISTIC CURVES
($V_{IN} = 5.0V$, $I_{OUT} = 0mA$, $T_A = 25^{\circ}C$ unless otherwise specified)

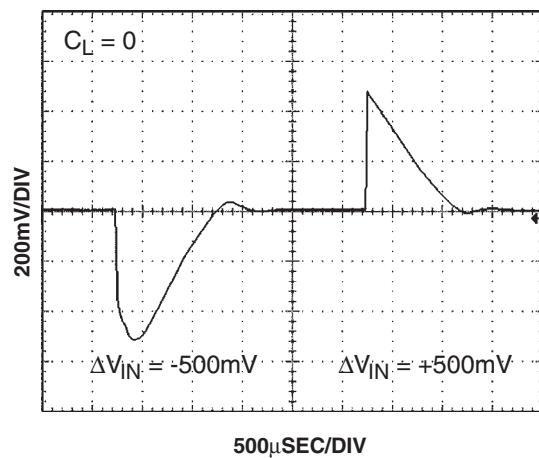
10mA LOAD TRANSIENT RESPONSE



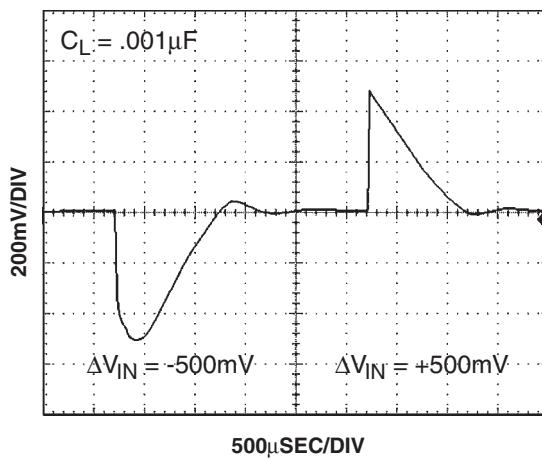
50 μ A LOAD TRANSIENT RESPONSE

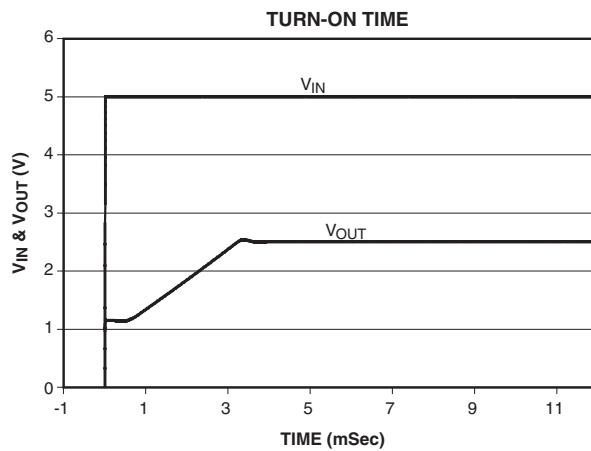
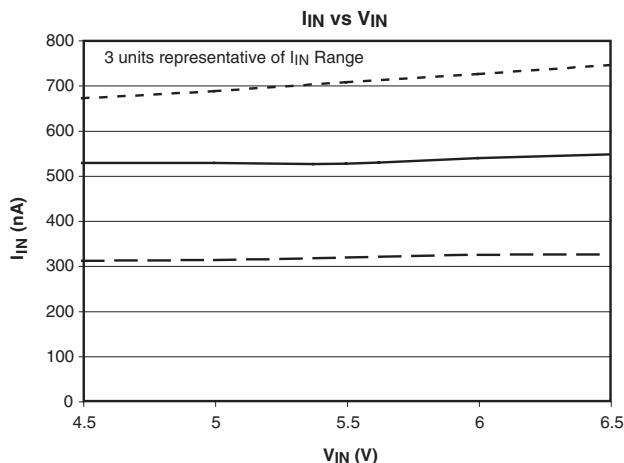
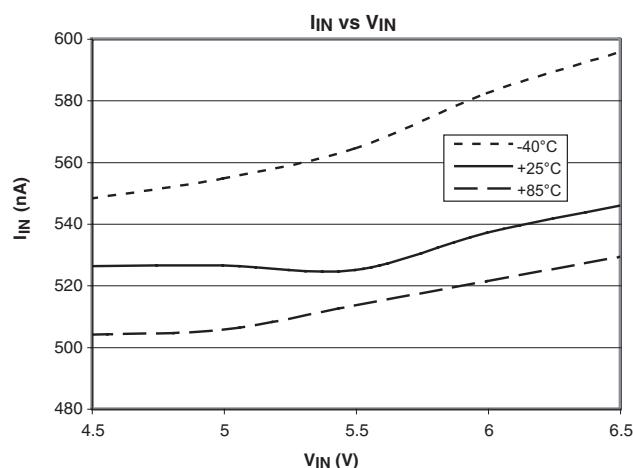
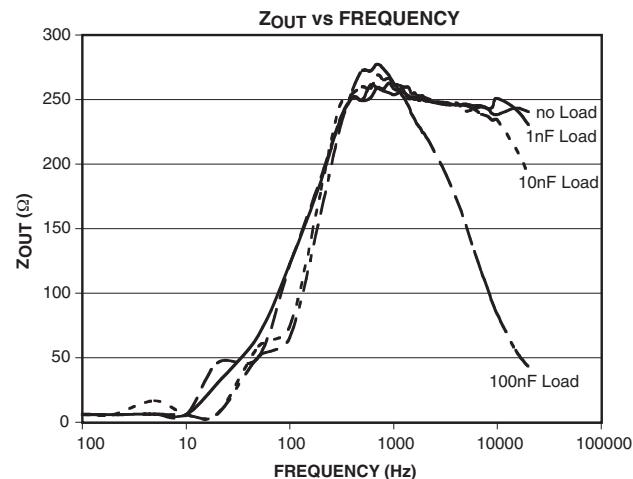


LINE TRANSIENT RESPONSE



LINE TRANSIENT RESPONSE



TYPICAL PERFORMANCE CHARACTERISTIC CURVES
($V_{IN} = 5.0V$, $I_{OUT} = 0mA$, $T_A = 25^{\circ}C$ unless otherwise specified)

APPLICATIONS INFORMATION

FGA Technology

The X60008 series of voltage references use the floating gate technology to create references with very low drift and supply current. Essentially the charge stored on a floating gate cell is set precisely in manufacturing. The reference voltage output itself is a buffered version of the floating gate voltage. The resulting reference device has excellent characteristics which are unique in the industry: very low temperature drift, high initial accuracy, and almost zero supply current. Also, the reference voltage itself is not limited by voltage bandgaps or zener settings, so a wide range of reference voltages can be programmed (standard voltage settings are provided, but customer-specific voltages are available).

The process used for these reference devices is a floating gate CMOS process, and the amplifier circuitry uses CMOS transistors for amplifier and output transistor circuitry. While providing excellent accuracy, there are limitations in output noise level and load regulation due to the MOS device characteristics. These limitations are addressed with circuit techniques discussed in other sections.

Nanopower Operation

Reference devices achieve their highest accuracy when powered up continuously, and after initial stabilization has taken place. This drift can be eliminated by leaving the power-on continuously.

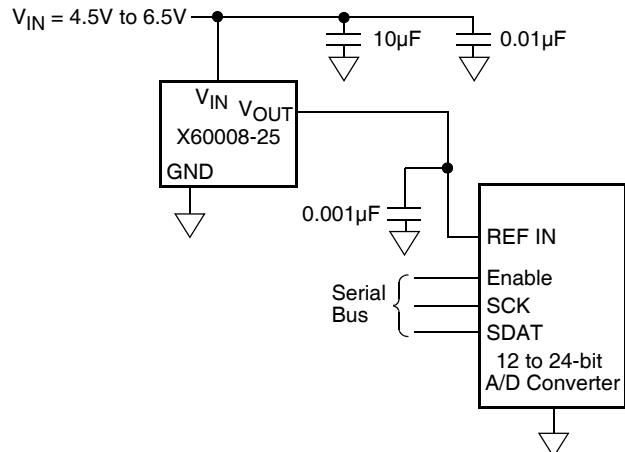
The X60008 is the first high precision voltage reference with ultra low power consumption that makes it possible to leave power-on continuously in battery operated circuits. The X60008 consumes extremely low supply current due to the proprietary FGA technology. Supply current at room temperature is typically 500nA which is 1 to 2 orders of magnitude lower than competitive devices. Application circuits using battery power will benefit greatly from having an accurate, stable reference which essentially presents no load to the battery.

In particular, battery powered data converter circuits that would normally require the entire circuit to be disabled when not in use can remain powered up between conversions as shown in figure 1. Data acquisition circuits providing 12 to 24 bits of accuracy can operate with the reference device continuously biased with no power penalty, providing the highest accuracy and lowest possible long term drift.

Other reference devices consuming higher supply currents will need to be disabled in between conversions to conserve battery capacity. Absolute accuracy will

suffer as the device is biased and requires time to settle to its final value, or, may not actually settle to a final value as power-on time may be short.

Figure 1.



Board mounting Considerations

For applications requiring the highest accuracy, board mounting location should be reviewed. Placing the device in areas subject to slight twisting can cause degradation of the accuracy of the reference voltage due to die stresses. It is normally best to place the device near the edge of a board, or the shortest side, as the axis of bending is most limited at that location. Obviously mounting the device on flexprint or extremely thin PC material will likewise cause loss of reference accuracy.

Noise Performance and Reduction:

The output noise voltage in a 0.1Hz to 10Hz bandwidth is typically 30μVp-p. This is shown in the plot in the Typical Performance Curves. The noise measurement is made with a bandpass filter made of a 1 pole high-pass filter with a corner frequency at .1Hz and a 2-pole low-pass filter with a corner frequency at 12.6Hz to create a filter with a 9.9Hz bandwidth. Noise in the 10KHz to 1MHz bandwidth is approximately 400μVp-p with no capacitance on the output, as shown in Fig. 2 below. These noise measurements are made with a 2 decade bandpass filter made of a 1 pole high-pass filter with a corner frequency at 1/10 of the center frequency and 1-pole low-pass filter with a corner frequency at 10 times the center frequency. Figure 2 also shows the noise in the 10KHz to 1MHz band can be reduced to about 50μVp-p using a .001μF capacitor on the output. Noise in the 1KHz to 100KHz band can be further reduced using a 0.1μF capacitor on the output, but noise in the 1Hz to 100Hz band increases due to instability of the very low power amplifier with a 0.1μF capacitance load. For

load capacitances above $.001\mu\text{F}$ the noise reduction network shown in fig. 3 is recommended. This network reduces noise significantly over the full bandwidth. As shown in fig. 2, noise is reduced to less than $40\mu\text{Vp-p}$ from 1Hz to 1MHz using this network with a $.01\mu\text{F}$ capacitor and a $2\text{k}\Omega$ resistor in series with a $10\mu\text{F}$ capacitor.

Figure 2.

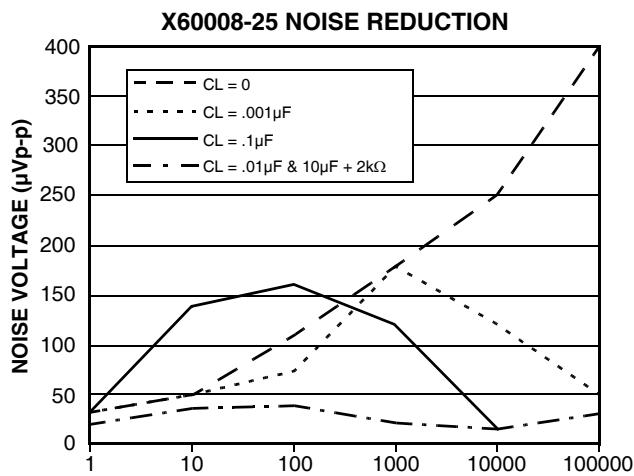
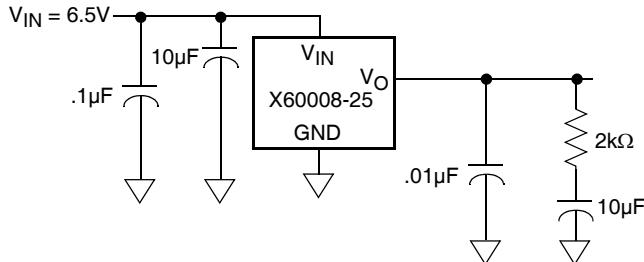


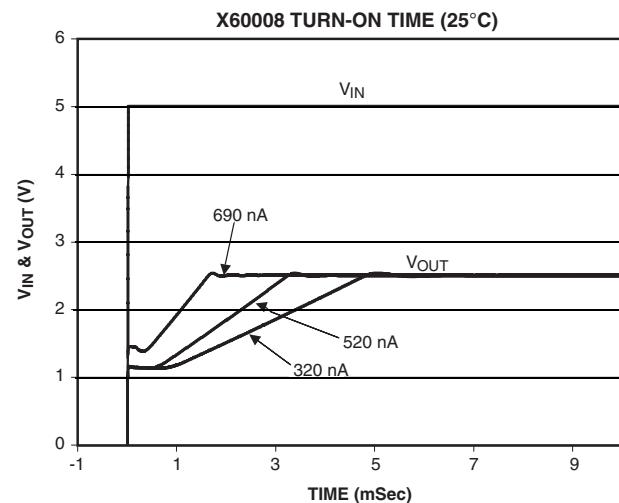
Figure 3.



Turn-On Time

The X60008 devices have ultra-low supply current and thus the time to bias up internal circuitry to final values will be longer than with higher power references. Normal turn-on time is typically 7ms. This is shown in the graph, Figure 4. Since devices can vary in supply current down to 300nA, turn-on time can last up to about 12ms. Care should be taken in system design to include this delay before measurements or conversions are started.

Figure 4.

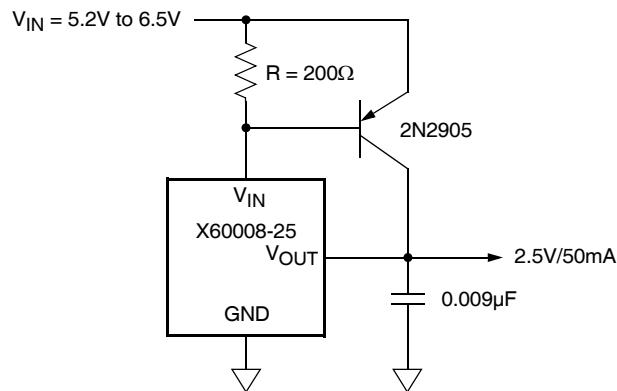


Temperature Coefficient

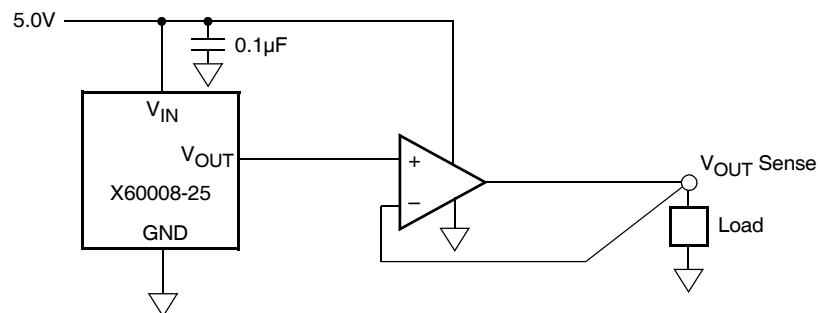
The limits stated for temperature coefficient (tempco) are governed by the method of measurement. The overwhelming standard for specifying the temperature drift of a reference is to measure the reference voltage at two temperatures, take the total variation, ($V_{\text{HIGH}} - V_{\text{LOW}}$), and divide by the temperature extremes of measurement ($T_{\text{HIGH}} - T_{\text{LOW}}$). The result is divided by the nominal reference voltage (at $T = 25^\circ\text{C}$) and multiplied by 10^6 to yield ppm/ $^\circ\text{C}$. This is the "Box" method.

TYPICAL APPLICATION CIRCUITS

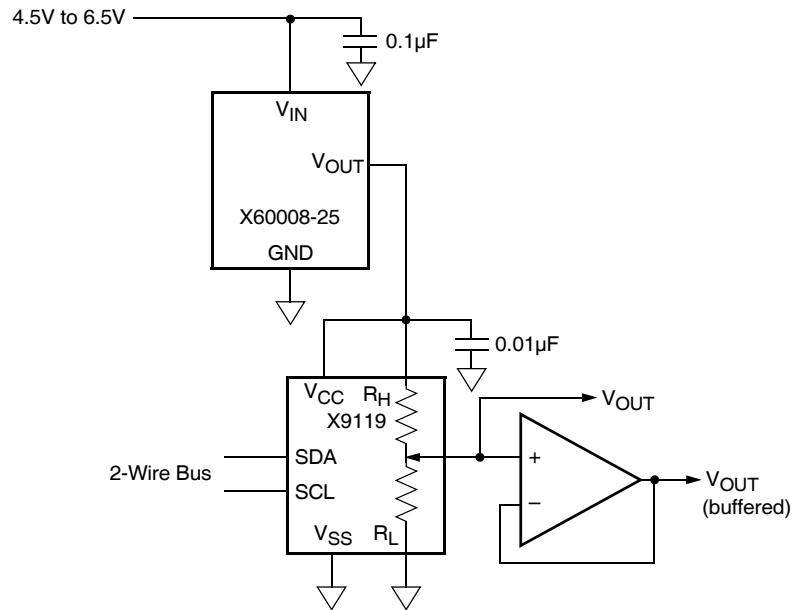
Precision 2.5V, 50mA Reference.

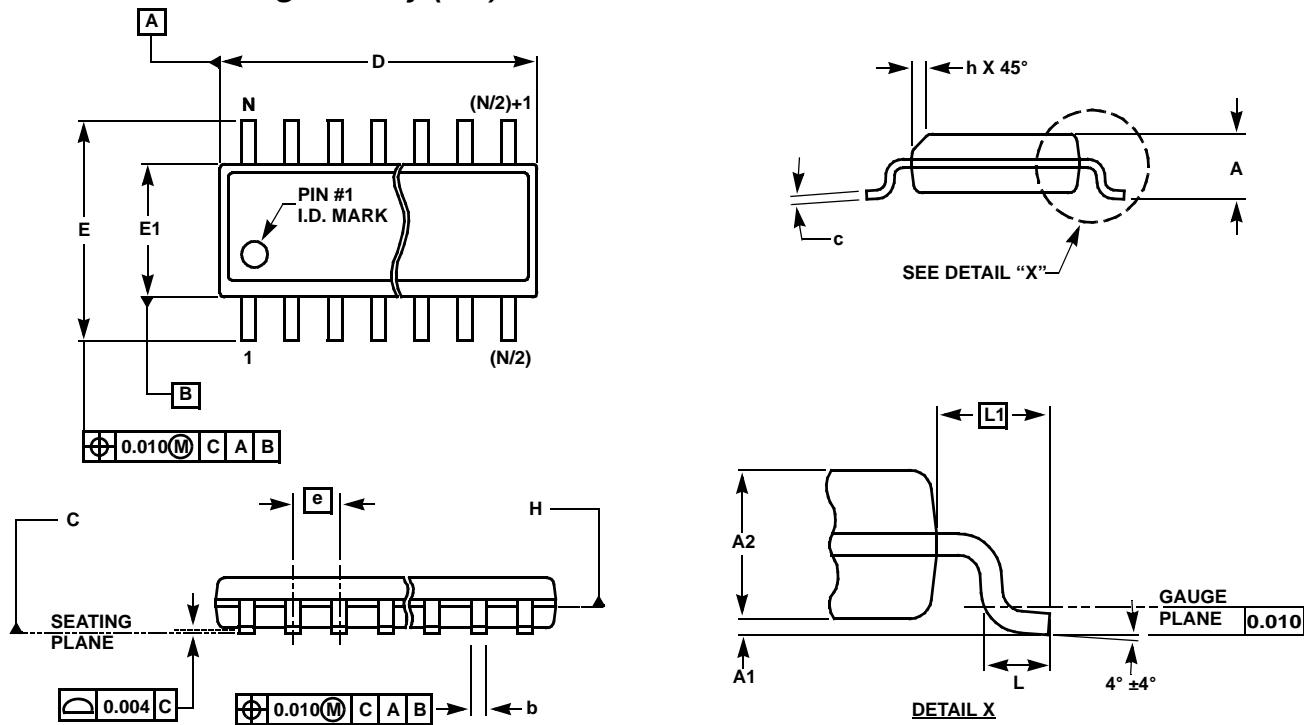


Kelvin Sensed Load



2.5V Full Scale Low-Drift 10-bit Adjustable Voltage Source



Small Outline Package Family (SO)**MDP0027****SMALL OUTLINE PACKAGE FAMILY (SO)**

SYMBOL	SO-8	SO-14	SO16 (0.150")	SO16 (0.300") (SOL-16)	SO20 (SOL-20)	SO24 (SOL-24)	SO28 (SOL-28)	TOLERANCE	NOTES
A	0.068	0.068	0.068	0.104	0.104	0.104	0.104	MAX	-
A1	0.006	0.006	0.006	0.007	0.007	0.007	0.007	±0.003	-
A2	0.057	0.057	0.057	0.092	0.092	0.092	0.092	±0.002	-
b	0.017	0.017	0.017	0.017	0.017	0.017	0.017	±0.003	-
c	0.009	0.009	0.009	0.011	0.011	0.011	0.011	±0.001	-
D	0.193	0.341	0.390	0.406	0.504	0.606	0.704	±0.004	1, 3
E	0.236	0.236	0.236	0.406	0.406	0.406	0.406	±0.008	-
E1	0.154	0.154	0.154	0.295	0.295	0.295	0.295	±0.004	2, 3
e	0.050	0.050	0.050	0.050	0.050	0.050	0.050	Basic	-
L	0.025	0.025	0.025	0.030	0.030	0.030	0.030	±0.009	-
L1	0.041	0.041	0.041	0.056	0.056	0.056	0.056	Basic	-
h	0.013	0.013	0.013	0.020	0.020	0.020	0.020	Reference	-
N	8	14	16	16	20	24	28	Reference	-

Rev. L 2/01

NOTES:

1. Plastic or metal protrusions of 0.006" maximum per side are not included.
2. Plastic interlead protrusions of 0.010" maximum per side are not included.
3. Dimensions "D" and "E1" are measured at Datum Plane "H".
4. Dimensioning and tolerancing per ASME Y14.5M-1994

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